



## COURSE DATA

### DATA SUBJECT

**Code:** 34791  
**Name:** Electronic and photonic devices  
**Cycle:** Undergraduate Studies  
**ECTS Credits:** 6  
**Academic year:** 2025-26

### STUDY (S)

Degree	Center	Acad. year	Period
1402 - Degree in Telecommunications Electronic Engineering	Escola Tècnica Superior d'Enginyeria	2	First quarter

### SUBJECT-MATTER

Degree	Subject-matter	Character
1402 - Degree in Telecommunications Electronic Engineering	Electronic and photonic components and circuits	BASIC

### COORDINATION

NAVARRO ANTON ASUNCION EDITH

## SUMMARY

This 6 ECTS subject is given in the first four-month period of the second course of the Grade of Telecommunication Electronics Engineering. The subject allows to the student to reach a basic electronic knowledge and is developed in 150 working hours for the student along the four-month period: 90 hours of self-organised work and 60 hours of classroom lessons.

This subject as part of the matter ¿Electronic and Photonic Components and Circuits¿ has a basic training nature and provides a basic knowledge about electronic and photonic components and circuits. As it is expressed in the contents of the Module of the grades in which this subject is given:"It offers to the students an introduction to electronic circuits. It will be described the physical and electronic operation, constituent materials and the circuital models of the different electronic and photonic devices. Also the basic knowledge of circuit theory and its application to the devices will be acquired¿. Also "the principles of digital logic will be known¿. It is intended, in this subject, ¿the students learn to understand the electronic circuits and its devices, they can apply the different techniques to solve and design circuits and how to use the electronic devices in these circuits¿.

Of all the contents of the subject ¿Electronic and Photonic Components and Circuits¿, the course ¿Electronic and Photonic Devices¿ is responsible of the description of the devices from inside the device to



its output characteristics in a macroscopic scale, including its equivalent circuits. At the end of the course there will be seen some circuits using these devices to emphasize the knowledge about their operation.

Apart from the purely theoretical contents, the course will provide the student with the general knowledge necessary to solve engineering problems. The knowledge of how to solve these problems will be acquired in the problem sessions of the course where the students must find solutions to problems whose approach requires obtaining several solutions prior to final result.

About the skills that are needed for any engineer, the course contributes with the knowledge necessary to assemble of basic circuits on laboratory boards. The course provides the student the skills of search the components needed in a circuit, schematic circuits understanding, assembly of several devices with common nodes, measure on the circuits with laboratory instrumentation, show a set of measurements both on a table and on a graph and, finally, interpretation of the above mentioned data once obtained.

The course general objectives are to provide the student the necessary knowledge to understand the inner behaviour of electronic and photonic devices, know how the internal space charge regions are produced and how the internal electric field and the contact potential are modified when a device is forward or reverse biased. Once the devices are understood from the internal point of view, its output characteristics and equivalent circuits are shown. To consolidate the material taught in the course, in the last part of the course several simple circuits where the devices learned are used will be seen.

## PREVIOUS KNOWLEDGE

### RELATIONSHIP TO OTHER SUBJECTS OF THE SAME DEGREE

There are no specified enrollment restrictions with other subjects of the curriculum.

### OTHER REQUIREMENTS

The needed background to follow the course is acquired in the Mathematics and Electronic Circuits courses taught in first year of the grade. Within this knowledge must be emphasized the integral and derivative operation, the recognition of graphs and the data extraction from them. For the last part of the course a basic understanding of circuit theory is needed.

## COMPETENCES / LEARNING OUTCOMES

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B4 - Understand and master the basic concepts of linear systems and the related functions and transforms, electric circuit theory, electronic circuits, physical principle of semiconductors and logic families, electronic and photonic devices, materials technology and their application to solve engineering problems.



G3 - Acquisition of the knowledge of the basic and technological subjects that allows students to learn new methods and theories and endows them with the versatility to adapt to new situations.

G4 - Ability to solve problems with initiative, decision-making and creativity, and to communicate and transmit knowledge, abilities and skills, understanding the ethical and professional responsibility of the activity of a telecommunications technical engineer.

G5 - Knowledge to carry out measurements, calculations, assessments, evaluations, loss adjustments, studies, reports, task planning, and other analogous work in the specific field of telecommunications.

## DESCRIPTION OF CONTENTS

### 1. Introduction

Topic 1: Introduction to semiconductor materials. Intrinsic and doped semiconductor materials. Doped techniques in semiconductor materials.

### 2. The semiconductor diode

Topic 2: The pn junction. The PN junction with and without polarization. The polarized PN junction. Currents in the PN junction. The static characteristic.

Topic 3: Types of diodes. The avalanche effect. The Zener diode. The Schottky diode. Parameters and characteristics of the different types of diodes. Datasheets.

Topic 4: Using diodes. Switching response. The small-signal model. Application examples using signal diodes. Circuits using Zener diodes.

PRACTICE 1: The junction diode. IV characteristic and its applications. (6 hours)

### 3. The bipolar transistor

Topic 5: PNP and NPN junctions without polarization and polarized. Operating regions based on the minority carriers concentration in the base. Parameters and currents depending on the internal characteristics of bipolar transistors. Parameters and characteristic curves of bipolar transistors.

Topic 6: Datasheets of bipolar transistors.

Topic 7: Use of bipolar transistors. Switching transients. The small-signal model. Examples of application of bipolar transistors.

PRACTICE 2: Obtaining experimental characteristic of the BJT for common emitter configuration. (3 hours)



## 4. The unipolar transistor

Topic 8: Internal structure of unipolar transistors. The MOSFET transistor. Operating regions and currents of unipolar transistors as function of their internal characteristics. Curves and characteristic parameters of the unipolar transistor.

Topic 9: Datasheets of unipolar transistors.

Topic 10: Using unipolar transistors. Switching study. The small-signal model. Application examples of unipolar transistors.

PRACTICE 3: MOSFET transistor. (3 hours)

PRACTICE 4: Switching bipolar and unipolar transistor: Comparative. (3 hours)

## 5. Families and logic gates

Topic 11: Logic gates.

PRACTICE 5: Logical gates. (3 hours)

## 6. Photonic devices

Topic 12: Light-sensitive devices. Photoresistor. Photodiode. Phototransistor. Light-emitting devices. LED.

PRACTICE 6: Applications of photoresistors, leds and solar cells. (3 hours)

PRACTICE 7: Individual Test (2 hours).

## WORKLOAD

### PRESENCIAL ACTIVITIES

Activity	Hours
Theory	30,00
Laboratory	20,00
Classroom practices	10,00
<b>Total hours</b>	<b>60,00</b>

### NON PRESENCIAL ACTIVITIES

Activity	Hours
Attendance at other activities	1,00
Individual or group project	0,00
Independent study and work	0,00
Preparation of lessons	39,00
Preparation for assessment activities	50,00
Resolution of case studies	0,00
<b>Total hours</b>	<b>90,00</b>



## TEACHING METHODOLOGY

### TECHNICAL LECTURES.

The technical lectures are master classes. During the master class the lecturer will ask some questions to the students to monitor the student progress in its self-organised work previous to each class. The master class will be supported by animated slides to improve the understanding of the abstract concepts involved in the devices junctions. All the support material used in the lectures (slides, papers, web links, bibliography, etc), will be available for the student in "Aula Virtual". Aula Virtual is an application developed by the University of Valencia that make easy and direct the access to the different teaching and administrative resources. Competencies G3 and B4 are worked.

### PROBLEM CLASSES.

The problem classes will be in the classroom with a smaller group of students that in the technical lectures. In the problem classes some of the more significant problems that appear in the Problem Sheet will be solved. The problems will be solved in the backboard by the professor or by the students. As in the technical lectures, all the teaching resources will be available in Aula Virtual. Competencies G4 and B4 are worked.

### LABORATORY SESSIONS

The laboratory sessions will be held in the laboratories of the ETSE. During the first half an hour of each laboratory session, the professor will evaluate the student self-organised work about the contents of the scheduled session. This evaluation will be done through some short questions, time scheduled of 15 minutes, or through some individual questions to the students in those groups with fewer students. Competencies G3, G4, G5 and B4 are worked.

### TUTORIALS

The students have a tutorial timetable to solve problems, doubts, work orientation, etc. The tutorial timetable is set at the beginning of the academic course. Competencies G3, G4, G5 and B4 are worked.

## EVALUATION

### THEORY-PROBLEMS EVALUATION.



The theory -problems part can be overcome by two methods, or continuous assessment or a final exam at the end of the semester.

- Continuous assessment system.

At the end of each U.T. there will be a multiple choice test with only theory questions. The multiple choice exams will have a 60% on the total rate. The grade of each test will be added to the next to calculate the final grade. No make-up tests are made. If you have chosen the continuous assessment, on the official exam date you will have only a problems exam. This exam has a 40% rate on the total mark. To average theory (multiple choice test) and problems the mark must be at least 5 in multiple choice test and 5 in problems test. (G3, G4, G5 and B4)

There will be a problems test (diodes only) at the end of the first thematic unit of one hour. If the mark obtained in this test is greater than 5, until 2 points will be added to the mark obtained in the final problems test (to be held on the official date), if the mark obtained in the final problems test is greater than 4 points. (G3, G4, G5 and B4)

If first exam notification is failed, the tests made during the year will have a 25% rate on second call (if the average mark of all test is greater than 3, otherwise the second exam notification will be like single assessment system) and problems test will have 75% rate.

- Single assessment system.

Consist of a final exam that will take place at the end of the semester (G3, G4, G5 and B4). This final exam will consist in performing a single test divided into two blocks. The first block with theoretic-practical activities and the second block will correspond to problems. The average of the qualifications of the two thematic blocks will be considered only if both blocks have been passed.

It is mandatory to pass both blocks with a mark over 5.

Students who have choose, **from the beginning of the course**, the single assessment system should inform personally to the professor in charge.

## **LABORATORY EVALUATION.**



The evaluation of the laboratory will be done, as in theory problems part, by two methods continuous assessment and final exam.

- Continuous assessment system. Continuous assessment is carried out attending at all laboratory classes and the resulting note will be the average of the individual final laboratory test with continuous assessment throughout the laboratory sessions. It is mandatory the attendance to all laboratory classes to pass the laboratory evaluation by using the continuous assessment system. Continuous assessment during the course will take into account the average grade obtained in the resolution of the laboratory handout and the grade obtained on the test prepared by the teacher previous to the resolution of the practice (with a rate of 35% and 15% respectively). This continuous assessment will be the 50% of the laboratory mark and the other 50% will be the mark obtained in the individual laboratory test scheduled in the last laboratory session (G3, G4, G5 and B4). The mark on this exam must be over 4.
- Single assessment system: the final exam. It consists of a laboratory final exam the same day scheduled for the final exam of theory-problems (G3, G4, G5 and B4). Students who has choose, **from the beginning of the course**, the single assessment system will also have to submit all the reports asked by the professor.

To pass the laboratory evaluation using continuous assessment system, the student should obtained grades higher than five in (n-1) of the laboratory sessions and in (n-1) of the tests made by the teacher previous to each laboratory session. Being n the number of laboratory sessions.

The student who has chosen from the beginning of course continuous assessment and has not succeeded the laboratory assessment has to do the final laboratory exam. The mark obtained in this exam will be the laboratory mark.

Students who have choose **from the beginning of the course** the single assessment system should inform personally to the professor in charge.

## COURSE EVALUATION.

The theory-problems rate is the 70% of the final mark and laboratory rate is the 30% in the final mark, being



indispensable to pass both parts.

The composition of the final grade for the course for continuous assessment system and single assessment system can be seen in the next tables.

### **Continuous Assessment System**

*Summary of the composition of the final grade for the Course*

<b>Activities or concepts to evaluate</b>	<b>Assessment Method</b>	<b>Partial Assessment %</b>	<b>Final Assessment %</b>
Theory-Problems	First announcement:		70 %
	a) Tests	60%	
	b) Problems	40%	
	Second announcement:		
a) Tests	25%		
b) Problems	75%		
Laboratory sessions	1) Previous issues	15%	30%
	2) Handouts	35%	
	3) Individual exam	50%	



<b>Total</b>			<b>100%</b>
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To average theory (multiple choice test) and problems the mark must be at least 5 in multiple choice test and 5 in problems test.

The student who has chosen from the beginning of course continuous assessment and has not succeeded the laboratory assessment, has to do the final laboratory exam. The mark obtained in this exam will be the laboratory mark.

Thee individual laboratory exam must be over 4 to average with the other issues.

Students who have choose **from the beginning of the course** the single assessment system should inform personally to the professor in charge.

**Single Assessment System**

*Summary of the composition of the final grade for the Course*

<b>Activity or concepts to evaluate</b>	<b>Assessment Method</b>	<b>% Final Assessment</b>
Teoria-Problemes	1) Final Exam:	
	a) Theoretic-practical activities	45 %
	b) Problems	25 %



Laboratory sessions	Laboratory final exam	20 %
	Submitted reports	10 %
<b>Total</b>		<b>100%</b>

The final exam is divided into two blocks (theoretic-practical activities and problems). The average of the qualifications of the two blocks will be considered only if both blocks have been passed.

In any case, the evaluation system will be governed by that established in the Reglament de Avaluació i Qualificació de la Universitat de València per a Graus i Màsters

(<https://webges.uv.es/uvTaeWeb/MuestraInformacionEdictoPublicoFrontAction.do?accion=inicio&idEdictoSeleccionado=5639>).

## REFERENCES

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